



Silicon Valley Test Conference

Wyndham Hotel, San Jose, California, USA

November 8th & 9th, 2010

ATE Loadboard Layout for High Density RF Applications

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In collaboration with:
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Martin Dresler
Vanessa Bischler



Abstract

The current success of smart-phones and the relentless trend to reduce cost and add capabilities every year are key drivers in the wireless semiconductor business. Combining various RF technologies into one device along with the desire for multi-site testing can easily increase the RF ATE test fixture port count to a range of 48 and beyond. While a few ATE vendors provide test equipment for this requirement, the question remains on how to manage the interfacing and the test fixture design for high density RF without losing performance.

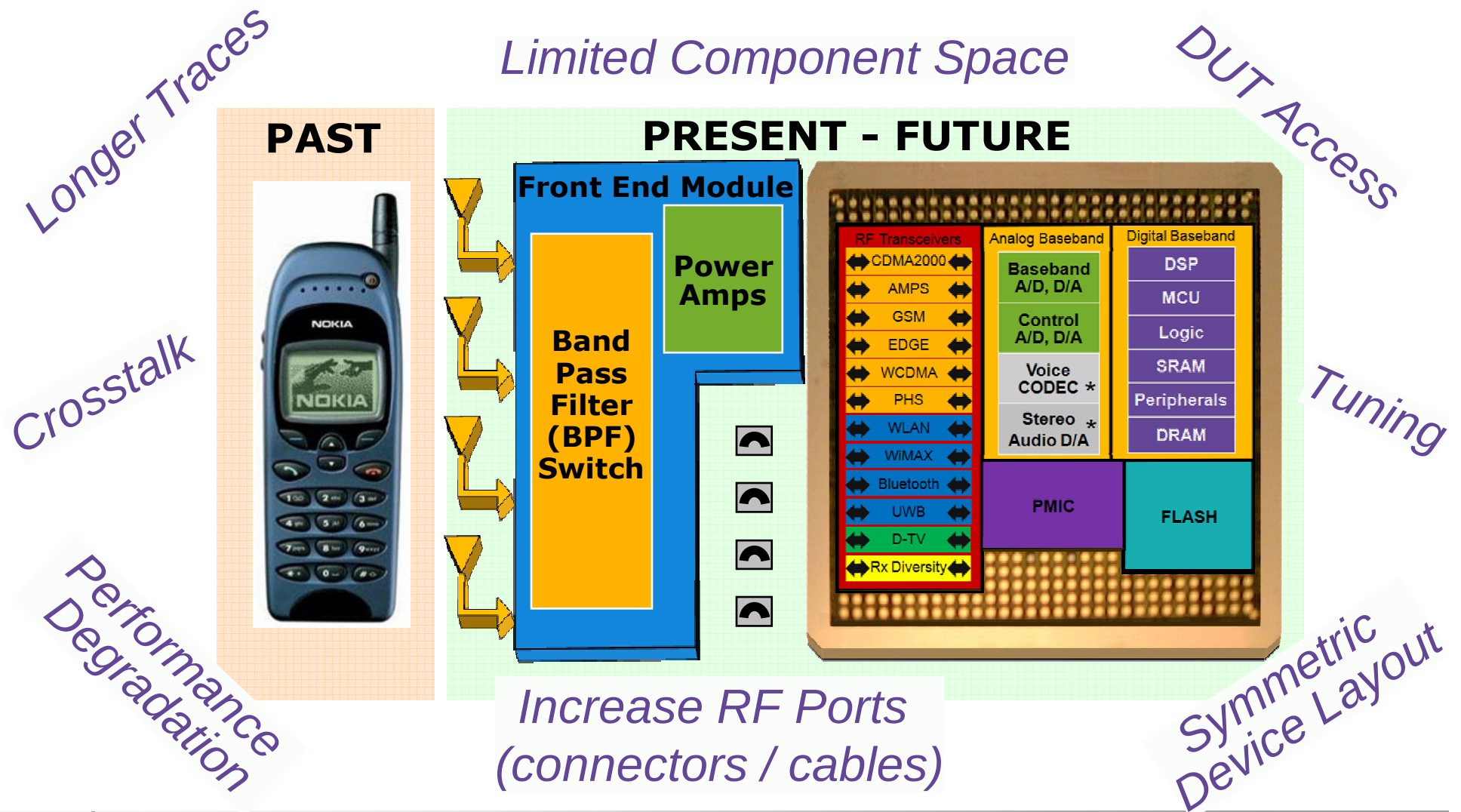
The current interfacing and layout paradigm will undergo a significant change. The RF connectors are moved further away from the DUT to allow easier assembly and debugging, but with higher risk of performance degradation due to loss, crosstalk and interference. The increase in the number of matching networks makes hand tuning a significant bottleneck in delivery of a working loadboard. This paper evaluates new hardware and layout techniques to address both mechanical and electrical performance for high density RF ATE test fixtures and applies this knowledge to measurement based modeling techniques to minimize hand tuning of RF matching networks.

Outline

1. Motivation and Concept
2. RF Cables
3. RF Connectors and Mounting Options
4. London Bridge (RF Interface)
5. Trace Design
6. Impact on RF Matching Networks
7. Summary

1. Motivation and Concept

RF Port Count Continues to Increase with Integration of Multiple Wireless Standards



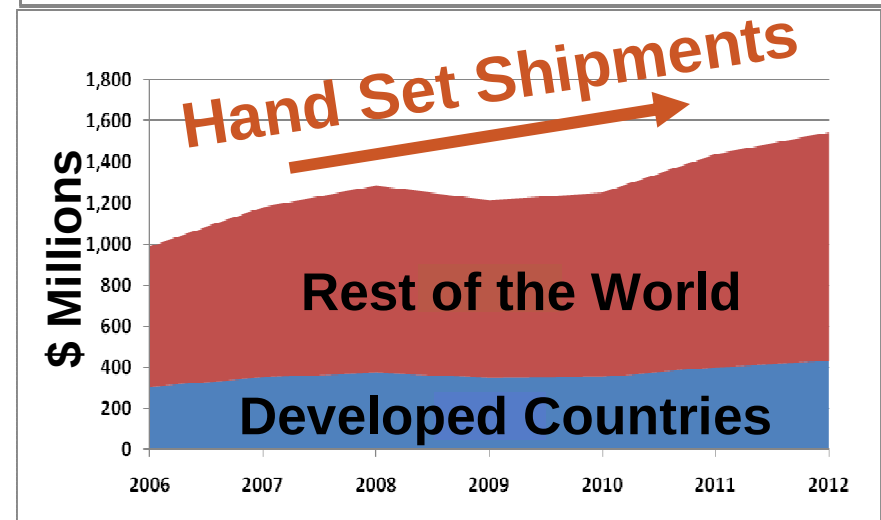
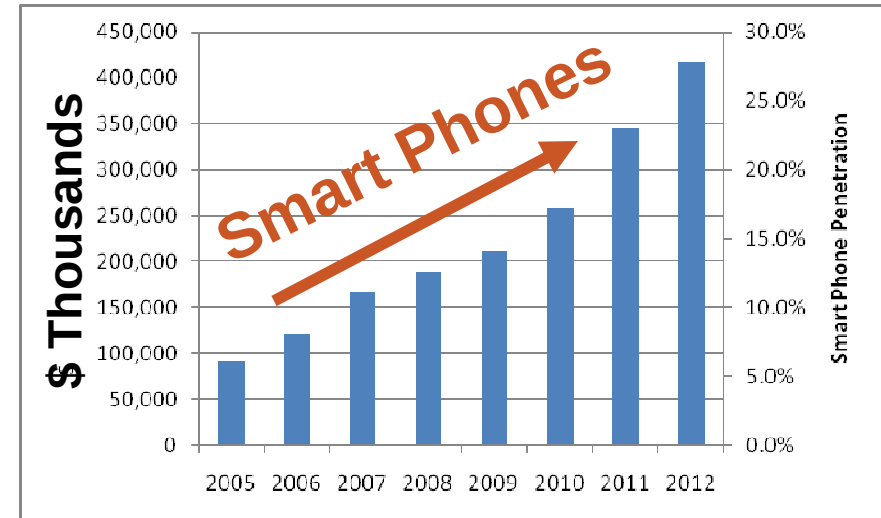
Market Reality and Test Implications

High End Handset

- Number of **RF ports increasing**
 - Multi-band
 - Receive diversity
 - Additional radio interfaces (WLAN, BT, GPS, FM Tx/Rx)
- **Smart phone** penetration accelerating
- Driving increase in RF port count for smart and high end feature phones
- **World phone** (3-4 bands) devices will drive multi-site **RF port count** requirements **above 24**

Ultra Low Cost Handset

- **1.8B new subscribers** from 2008 to 2012, 93% from developing countries
- **ULC Handset (\$20 BOM)** driving single chip SOC devices for entry level phones
- Limited RF port count required (<24)
- Cost goals driving **increase in multi-site (X4 → X8)**

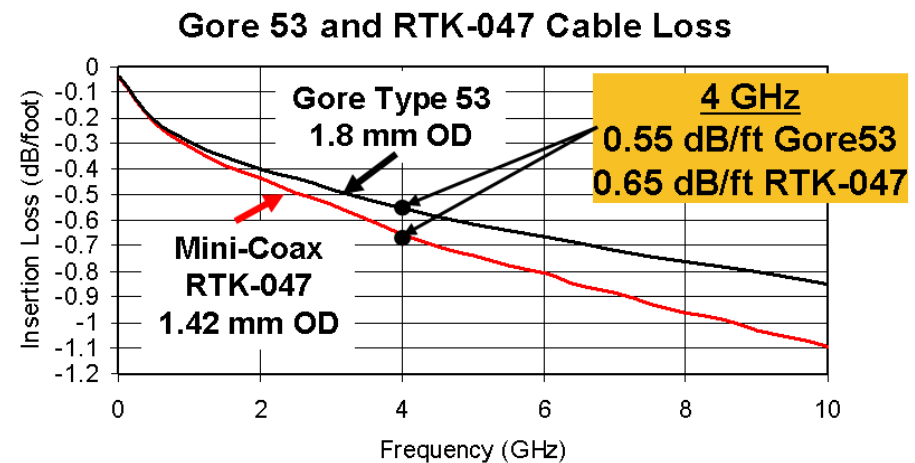
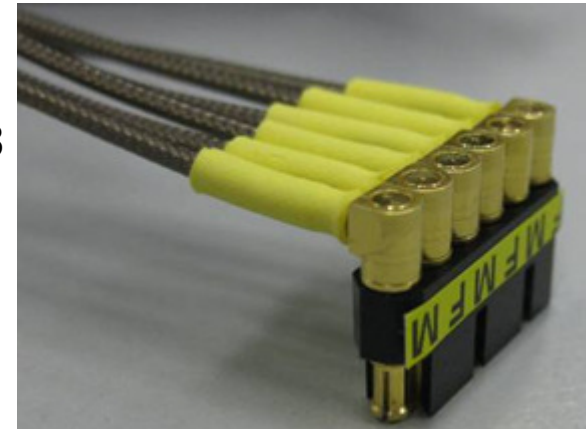


iSuppli data Q408

2. RF Cables

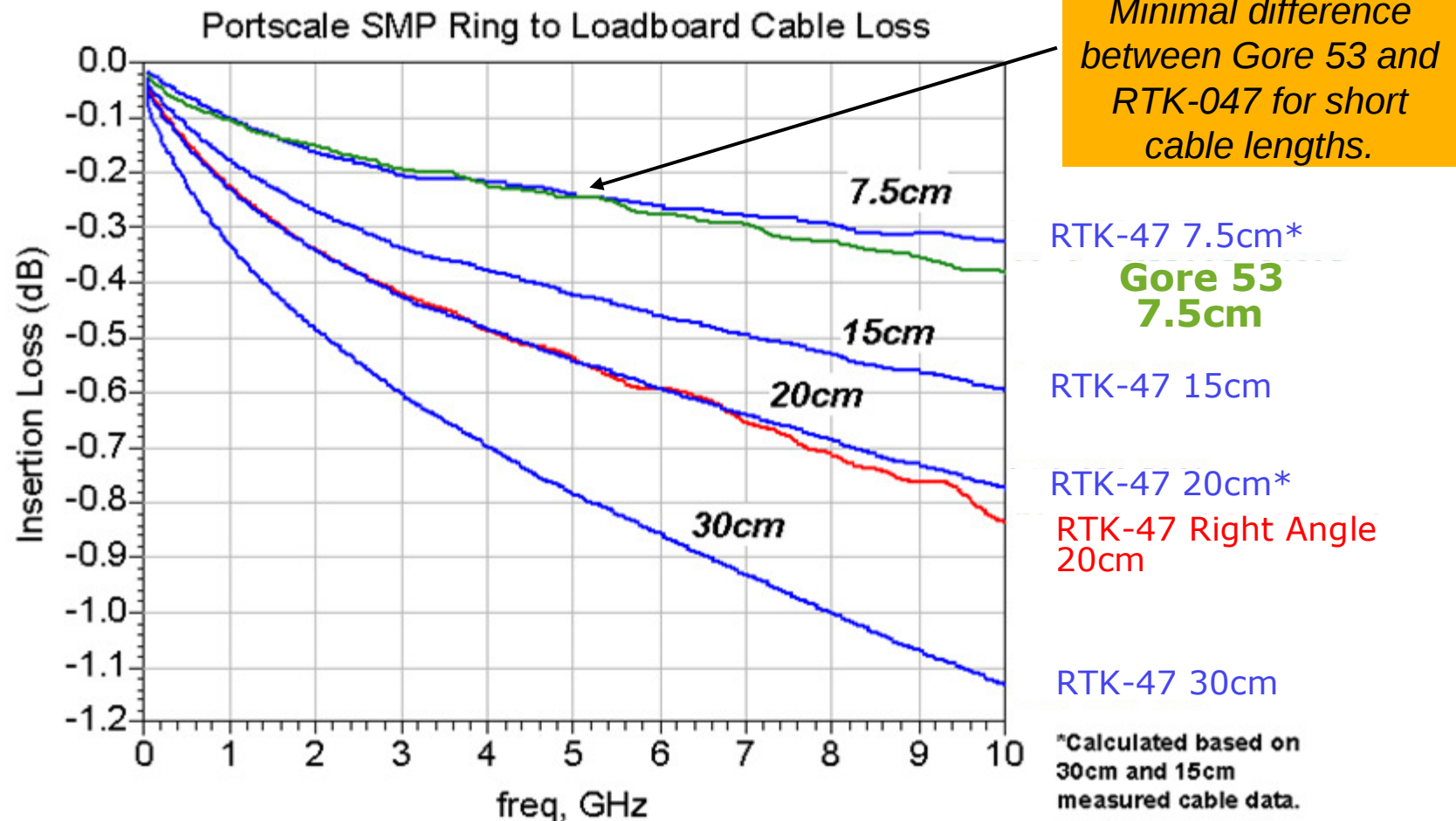
High Density RTK-047 Tempflex Cable

- Small: 1.42mm Diameter vs. 1.8mm for Gore 53
- Low Loss Dielectric: $dK=1.25$
- Flexible: 6.4mm Bend Radius vs. 10.2mm for Gore 53
- Different lengths: 15cm / 20cm / 25cm
- Robust: Ganged housing with strain relief
- Less space:
 - Increases routing flexibility
 - Enables smooth operation with RF interface ring



Measured Cable Performance

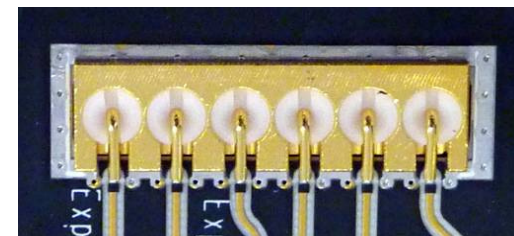
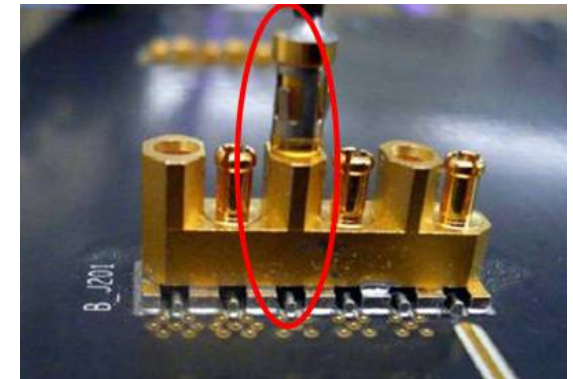
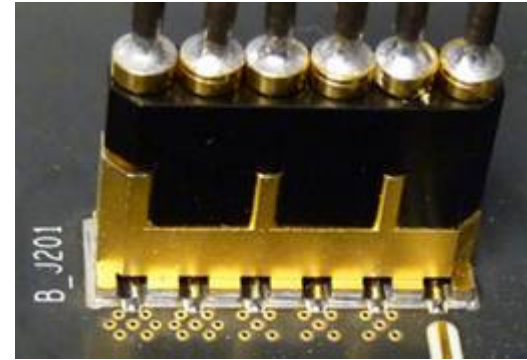
Full S-Parameter data includes cable loss and connectors



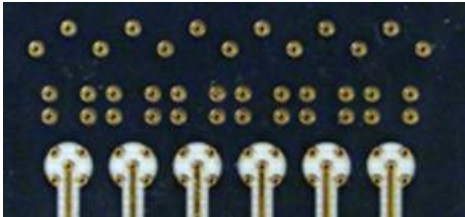
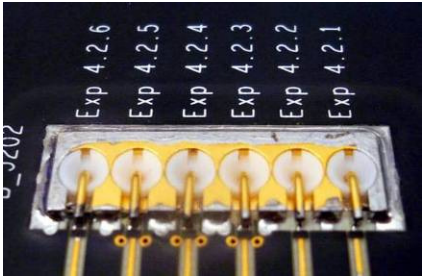
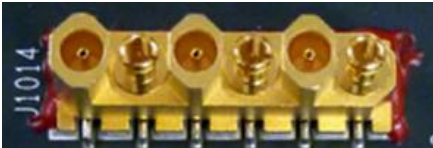
3. RF Connectors and Mounting Options

High Density Ganged Mini-Coax Connector

- 6x Ganged
- Share mechanical structure:
Reduces the size by 30%
- Increased mechanical robustness
- Individually replaceable cable by removing from housing
- Disengagement force $< 24\text{ N}$
vs. single Mini-SMP full detent connector $< 29\text{ N}$
- Engagement force $< 12.5\text{ N}$
vs. single smooth bore Mini-SMP $< 11\text{ N}$
- Mating cycles > 500 vs.
500 cycles SMA connectors.
100 cycles Mini-SMP connectors



Mounting Options

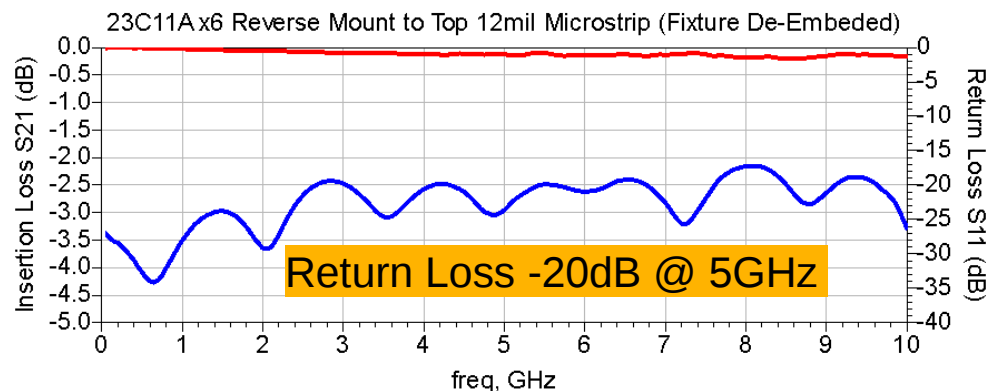
Standard Mount topology	Reverse Mount topology
Signal pin to bottom layer microstrip	Signal pin to top layer microstrip
Vias required to connect to an inner or to the Top layer Microstrip	No Via required for Top layer Microstrip
Blind vias under the connector body can completely open up the space for digital routing layers.	Through hole slot completely blocks routing on all layers
Cable connection on bottom side of PCB	Cable connection on bottom side of PCB
	
	

Top Side

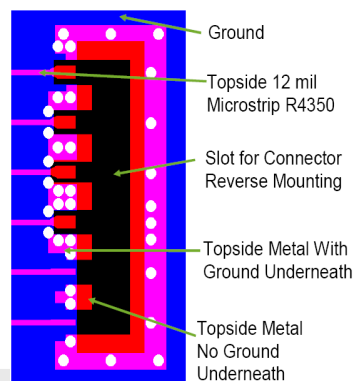
Bottom Side

Reverse Mount RF Performance

Full S-Parameter Data for Mini-Coax Connector to PCB Transition

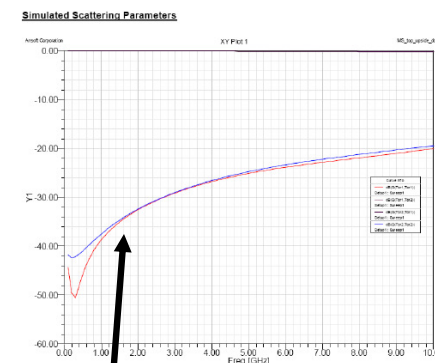
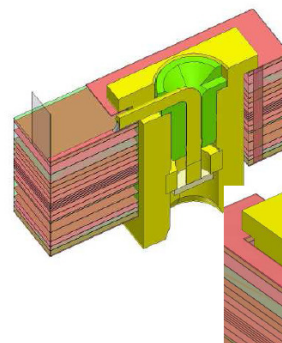


PCB footprint experiments to compare mechanical and electrical signal pin trade-offs.



Simulations

23C11A-40M
on
RO4350 + N4000-13, 5079 μm thick
Multilayer
50 Ohm Microstrip Line on TopLayer, mounted upside down on top

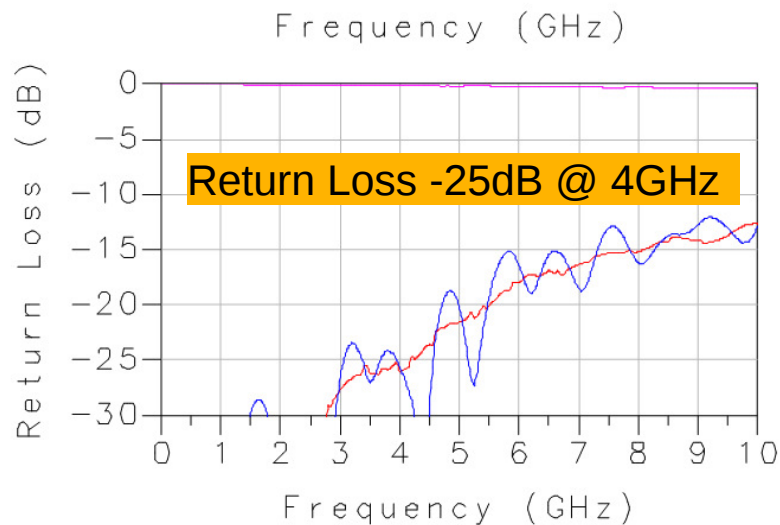


V0015_Rosenberger_23C11A_40M_MiniCoax_x6_Reverse_Top_SMT.zip

PCB footprints in dxf
and Gerber format

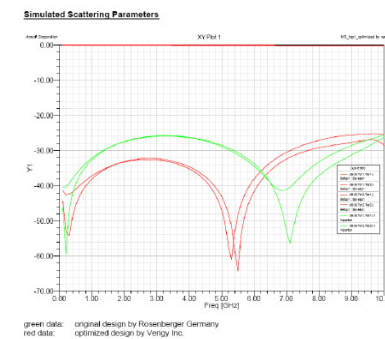
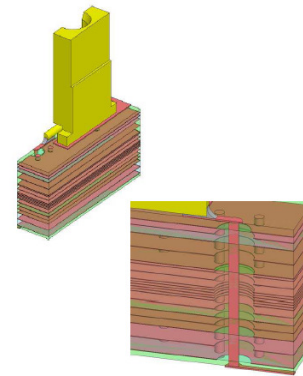
Standard Mount RF Performance

Full S-Parameter Data for Mini-Coax Connector to PCB Transition

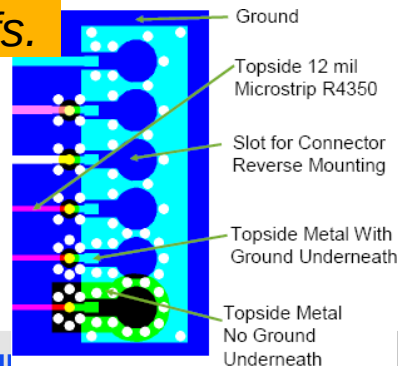


Simulations

23C11A-40M
on
RO4350 + N4000-13, 5079 μm thick
Multilayer
0 Ohm Microstrip Line on TopLayer, bottom mounted



PCB footprint experiments to compare mechanical and electrical signal pin trade-offs.



PCB footprints in dxf and Gerber format

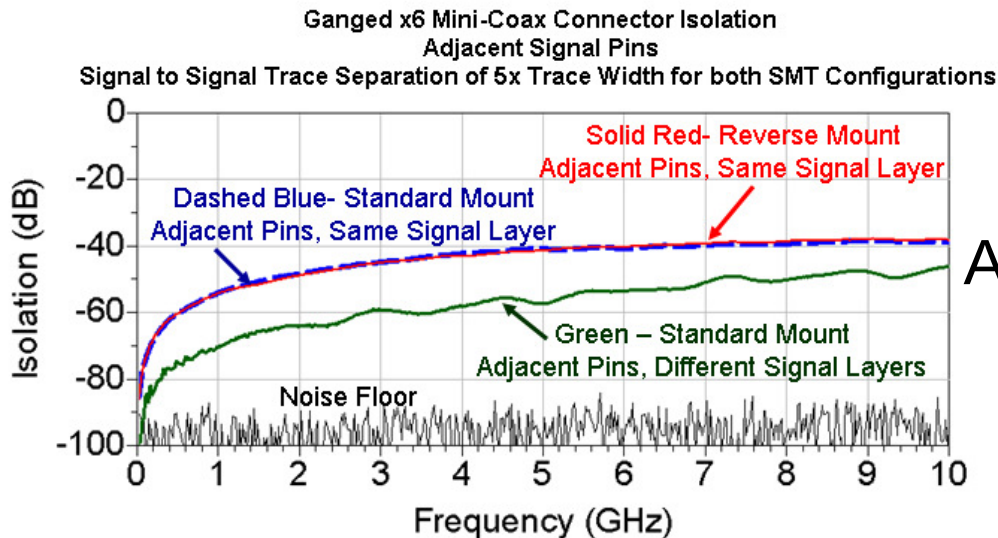


V0016_Rosenberger_23C11A_40M_MiniCoax_x6_Bot_SMT.zip

Ganged Connector Isolation

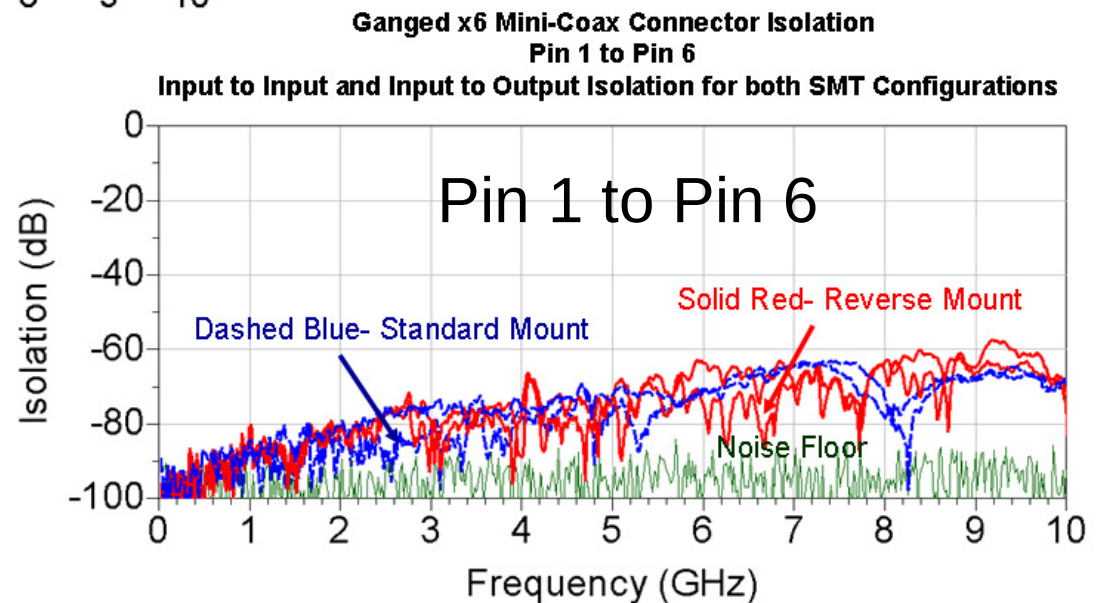
3 mm Signal Pin to
Signal Pin Spacing

Adjacent Signal Pins



Standard Mount with vias to topside and reverse mount with no vias show similar performance for isolation.

Stripline routing on different layers but adjacent connector pins improves isolation by >10 dB.



4. RF Interface: London Bridge

London Bridge RF Interface Ring (1/2)

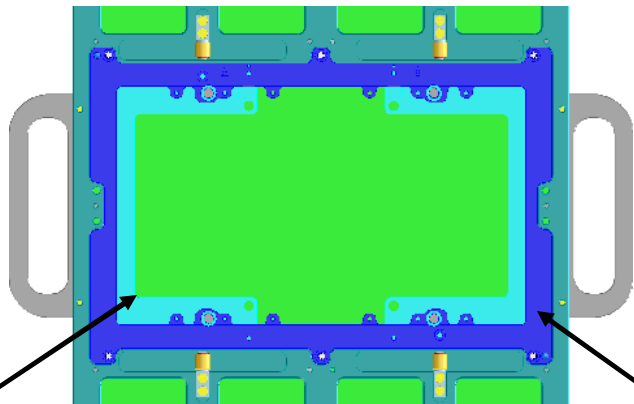
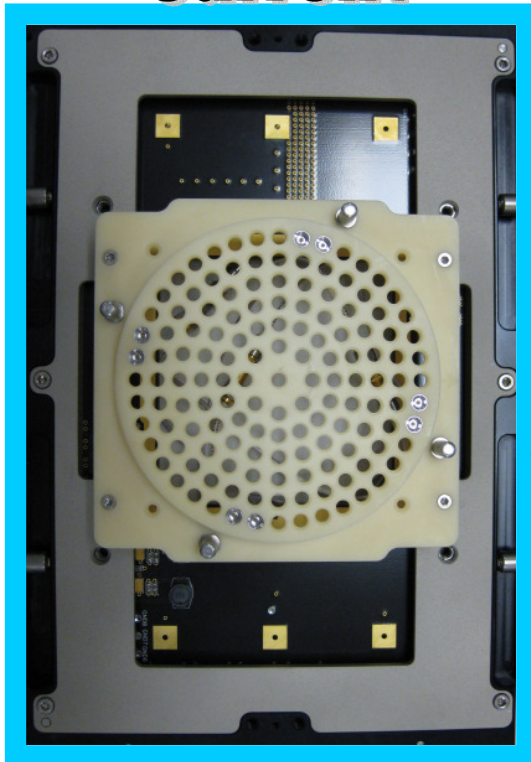
- Access to component area:
 - can be opened in the middle
 - can be lifted on either side and completely disengaged
- RF cables can be shorter for lower loss and less cable congestion
- Divided into 8 segments with 12 RF connections each. Easier assembly and better cable arrangement.
- Additional cavities in the ring frame allow unthreading the segment together with the cables.



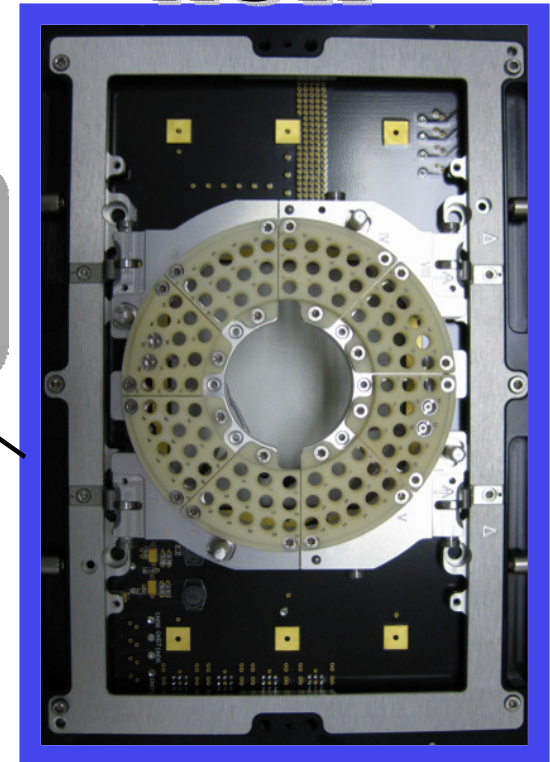
London Bridge RF Interface Ring (2/2)

- New metal inlay frame with increased application routing area by 30%.

Current



New

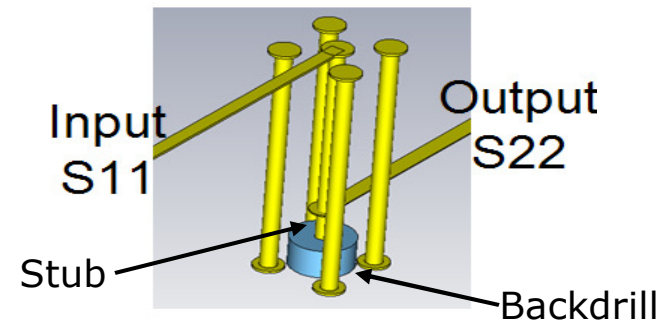


5. Trace Design Experiments

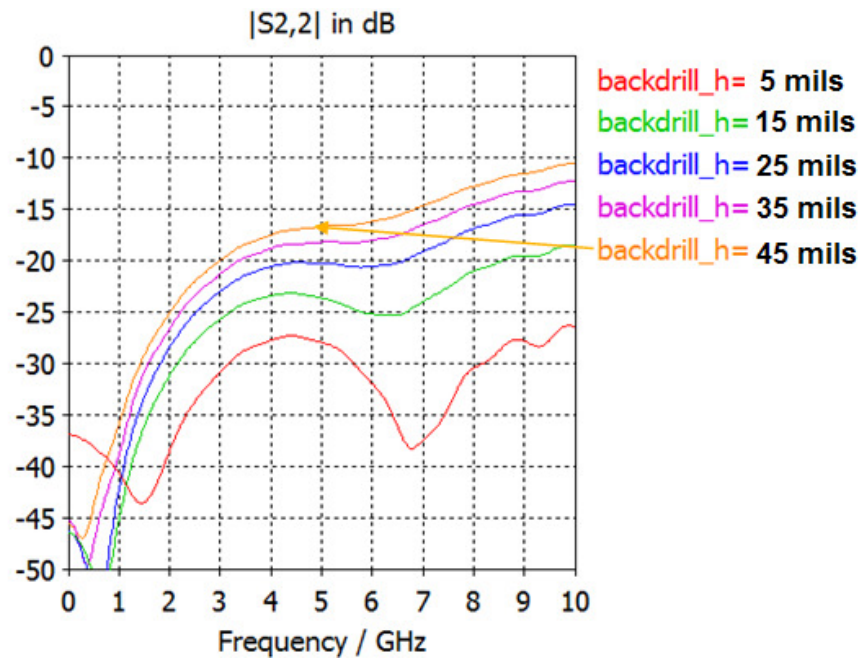
- ✓ Vias
- ✓ PCB Materials
- ✓ Isolation for Striplines and Microstrip Routing

Importance of Backdrilled Vias

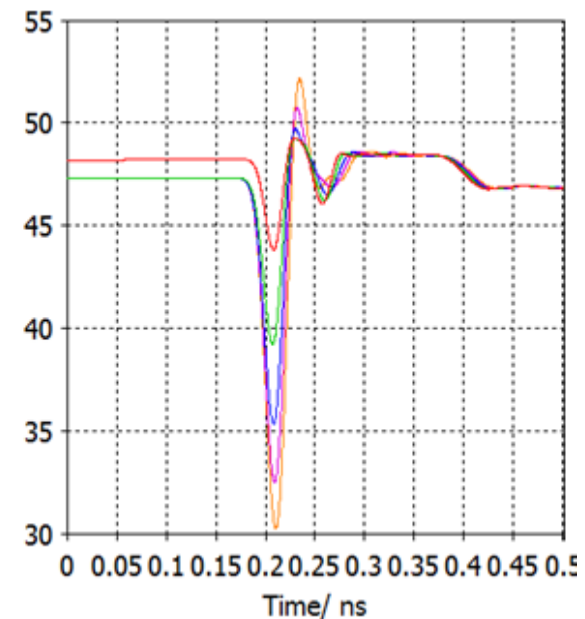
PCB Via
4 Ground Topology
50 Ohms



Return Loss vs Stub Length

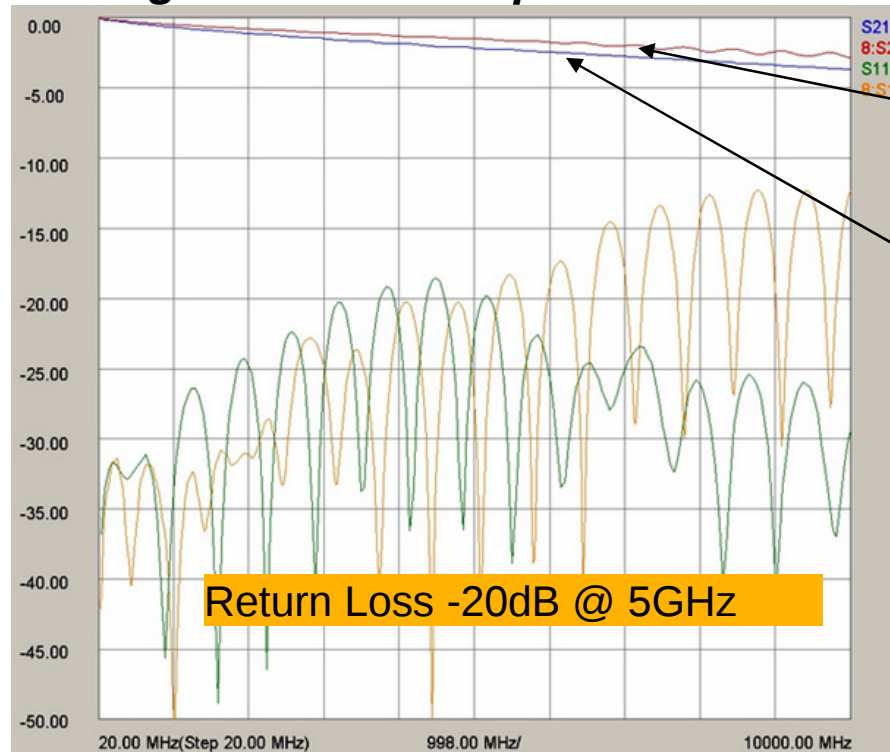


Via Impedance vs Stub Length



Signal Path with 2 Optimized 50 Ohm Vias

**TRL Calibration Thru-Line with Southwest Microwave
2.4 mm edge launch and optimized 50 ohm Vias.**



**R4350 Stripline (18mil)
in red and orange**

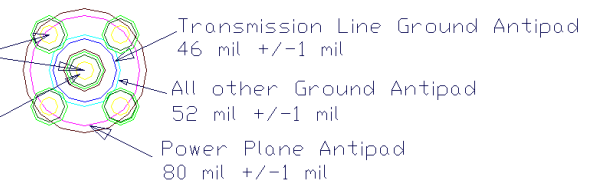
**Nelco 4000-13SI Stripline (19mil)
in blue and green**

Verigy Optimized Via

Verigy Optimized 50 ohm Via
13 mil Drill Signal Via with Stub Removal

rev 2 04102009

Plated Via, 5 places
13 +/-1 mil Drill
23 mil Pad



Backdrill Signal Via
Stub Length 20 mil +/-10 mil
Diameter 16 mil min, 30 mil max

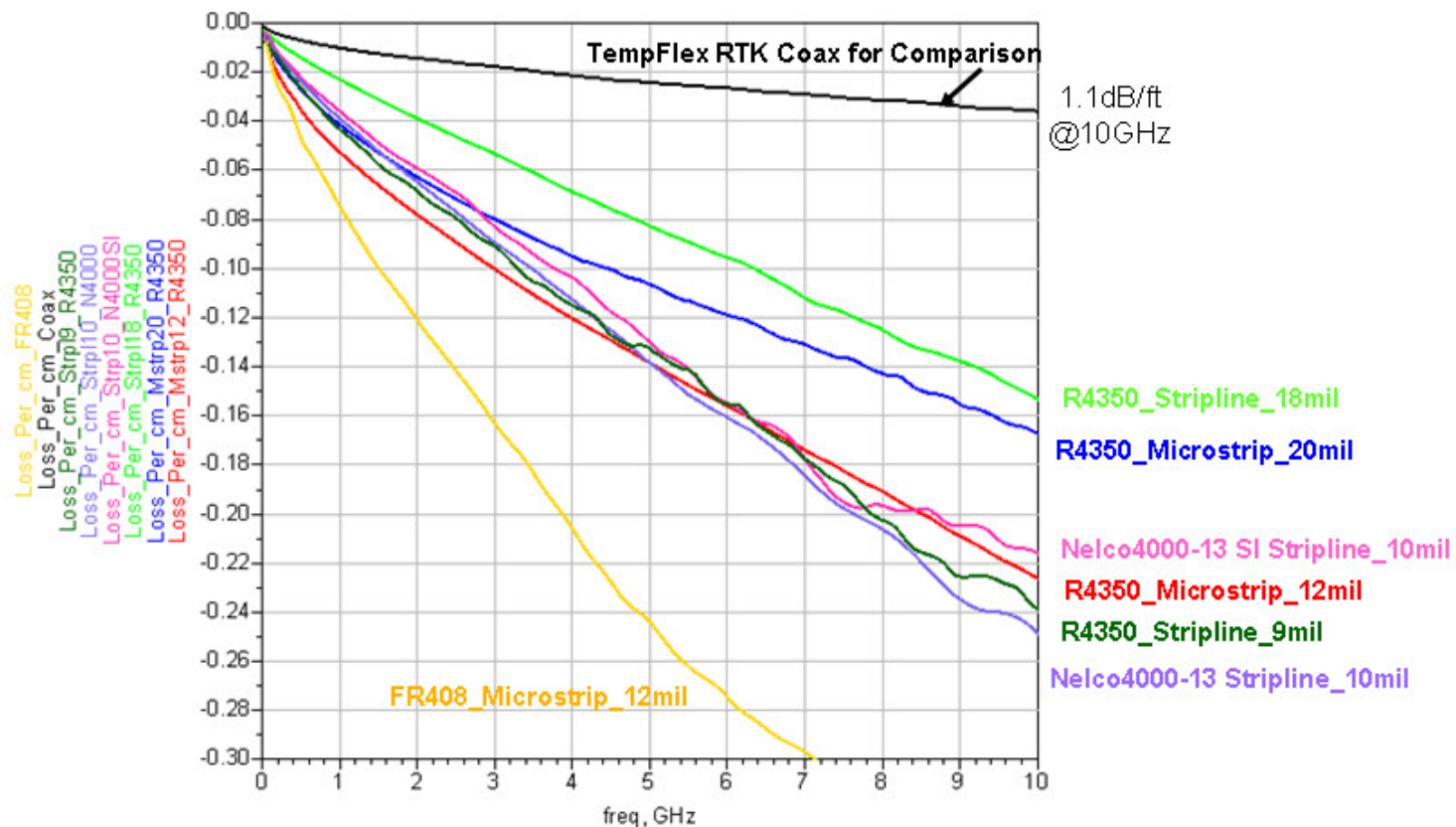
**4-ground vias on the
optimized via provide
better isolation and
robust implementation.**

Outline (5. Trace Design Experiments)

- ✓ Vias
- ✓ PCB Materials
- ✓ Isolation for Striplines and Microstrip Routing

PCB Materials for Longer High Density Routing

Fixture Removed, Loss Per Centimeter Data



Outline (5. Trace Design Experiments)

- ✓ Vias
- ✓ PCB Materials
- ✓ Isolation for Striplines and Microstrip Routing

Ground Via Stitching to Fence Off X-Talk

Isolation by separation (no via stitching)



Isolation by Guard Trace

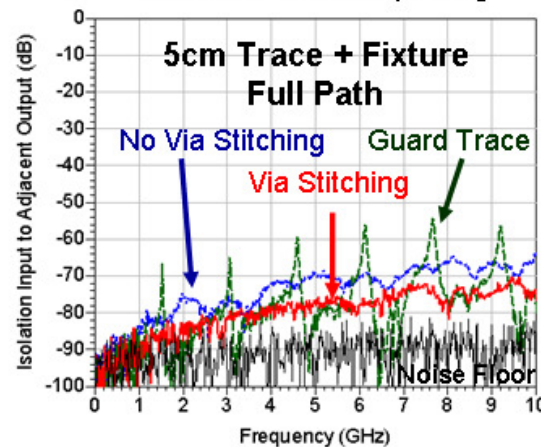


Isolation by Via Stitching

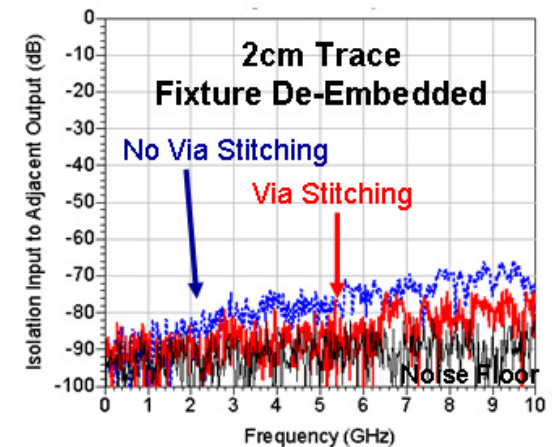


Stripline Isolation
5x Trace Width Spacing

Stripline

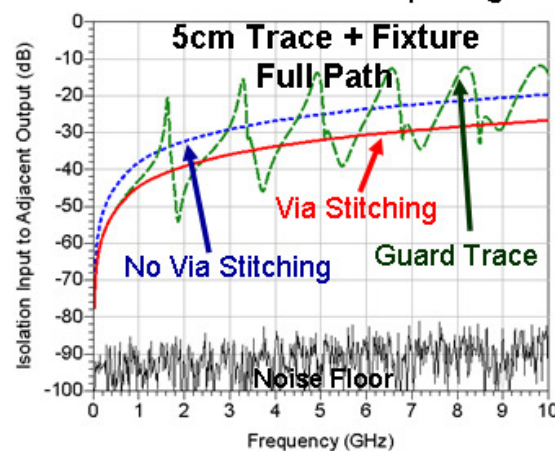


Stripline Isolation
5x Trace Width Spacing

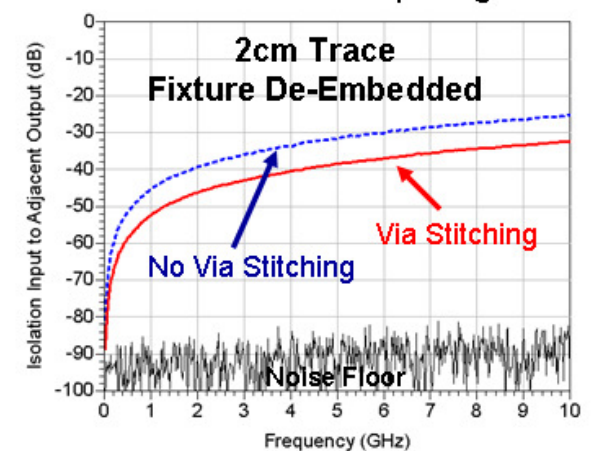


Microstrip Isolation
5x Trace Width Spacing

Microstrip



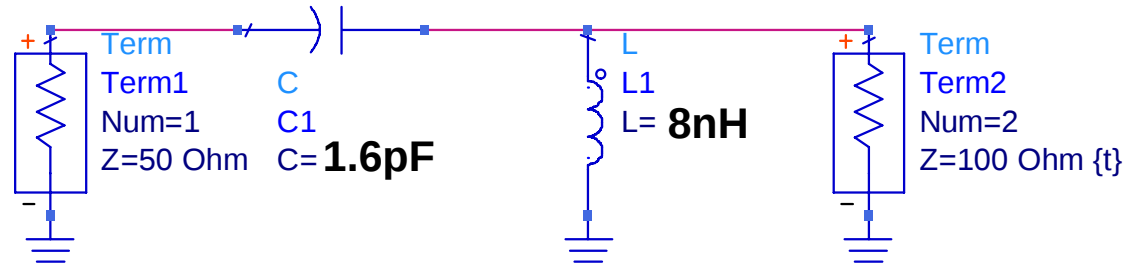
Microstrip Isolation
5x Trace Width Spacing



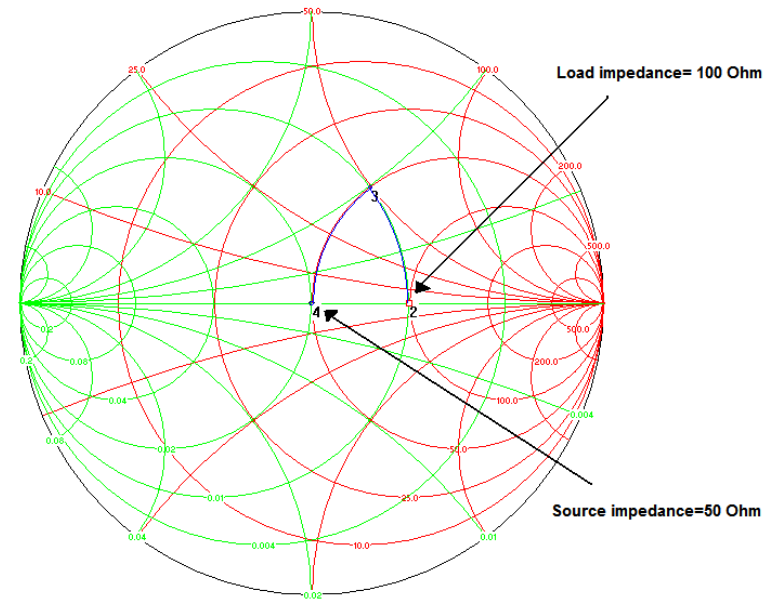
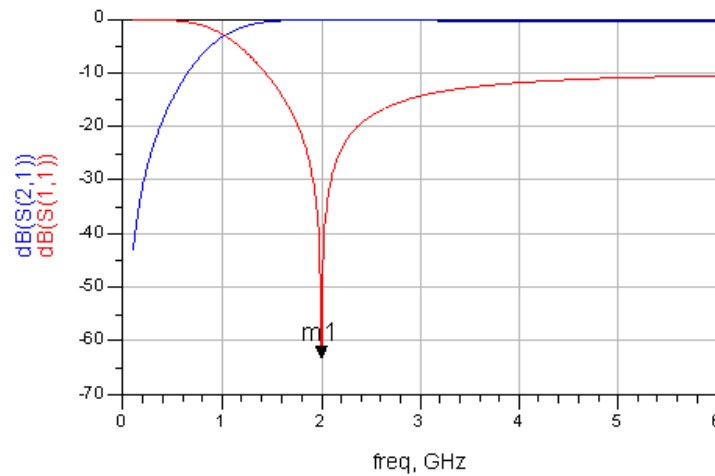
Outline

6. Impact on RF Matching Networks

Simple Matching Network Example



Lumped Model Design
for 2 GHz Match



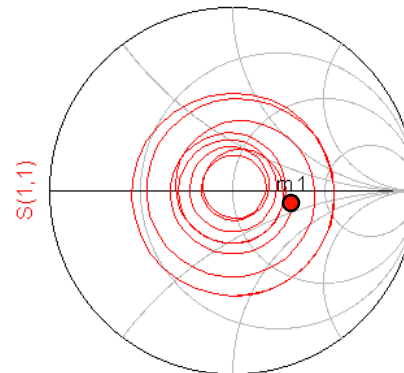
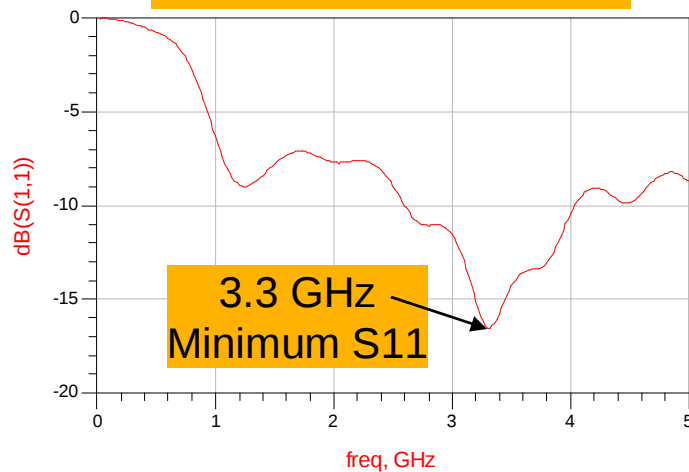
T-Line Affects on the Matching Network

The real load is complex 98-J10.9

Rotation by Transmission-Line distances places the load on the other side of the SMITH Chart making it impossible to get a good match with the Series C followed by Parallel L Network.

Simulations need accurate load measurements and flexibility in matching network design to allow for phase rotation of the load to the matching network.

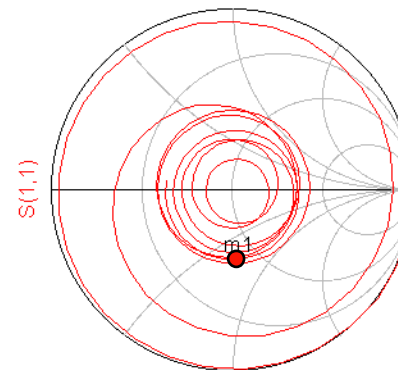
Measurement of
Lumped Model Design
for 2 GHz Match



Load Impedance

m1
freq=2.000 GHz
 $S(1,1)=0.332 / -8.575$
impedance = $Z_0 * (1.962 - j0.218)$

freq (20.00MHz to 5.000GHz)



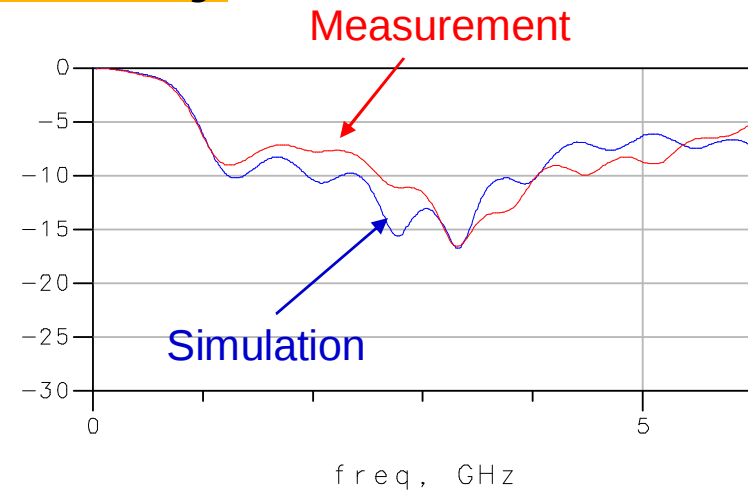
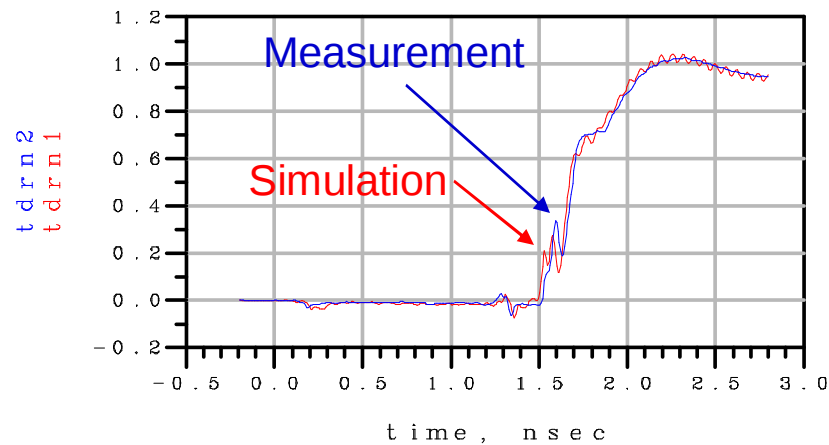
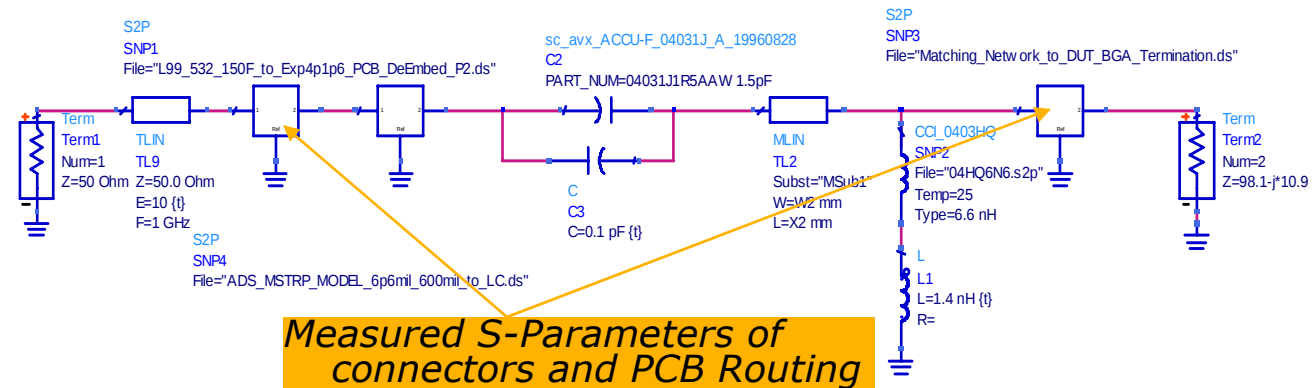
Load Impedance at the
Matching Network

m1
freq=2.000 GHz
 $S(1,1)=0.411 / -84.759$
impedance = $Z_0 * (0.760 - j0.748)$

freq (20.00MHz to 5.000GHz)

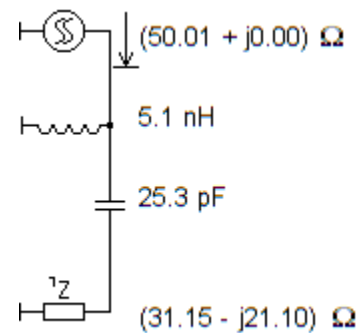
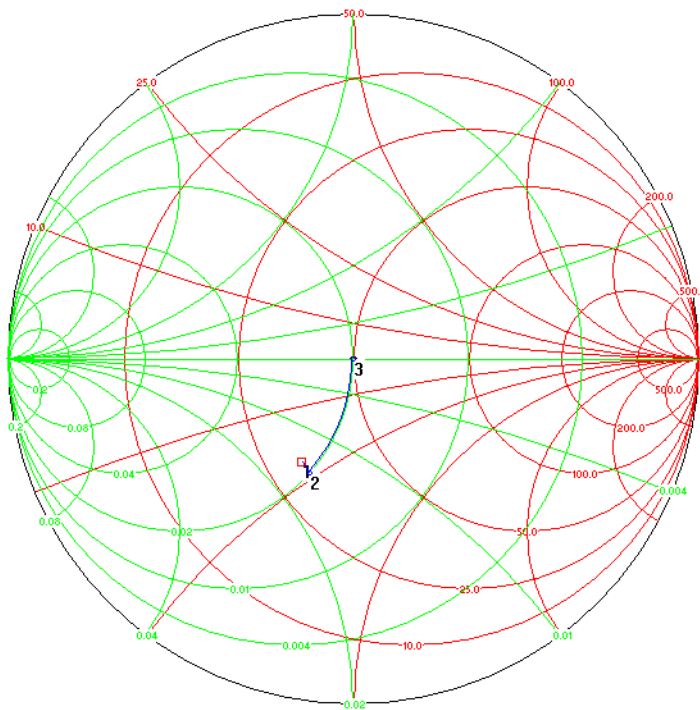
Measurement Based RF Tuning Approach

Verification of Measurement Based Model with Measured Data



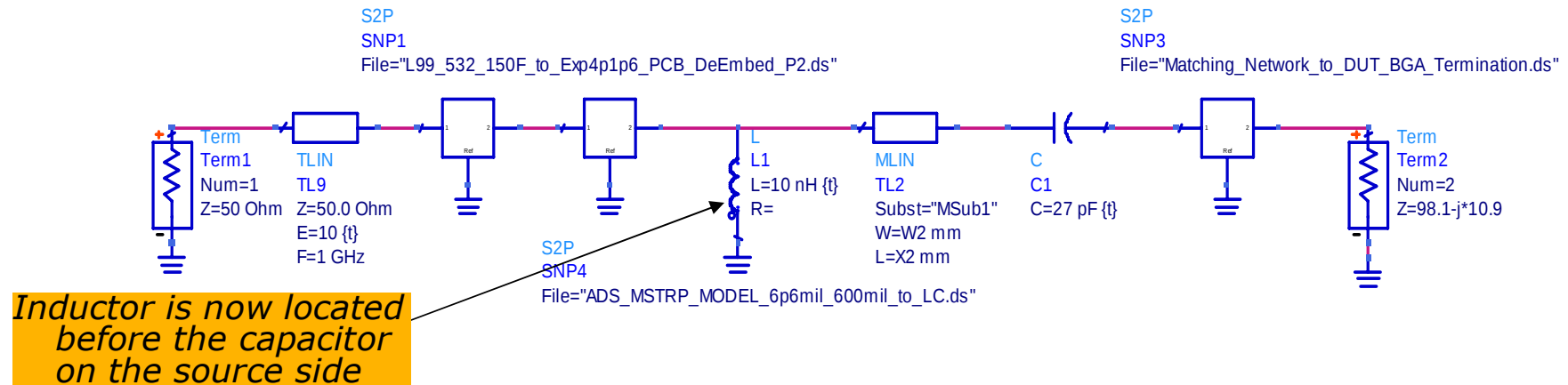
New Matching Network Topology for Rotated Load Impedance

Impedance matching on the Smith Chart:

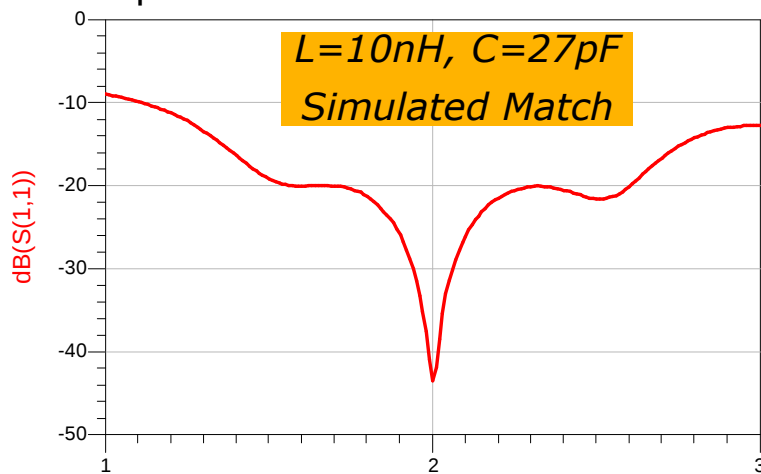


→correct topology!

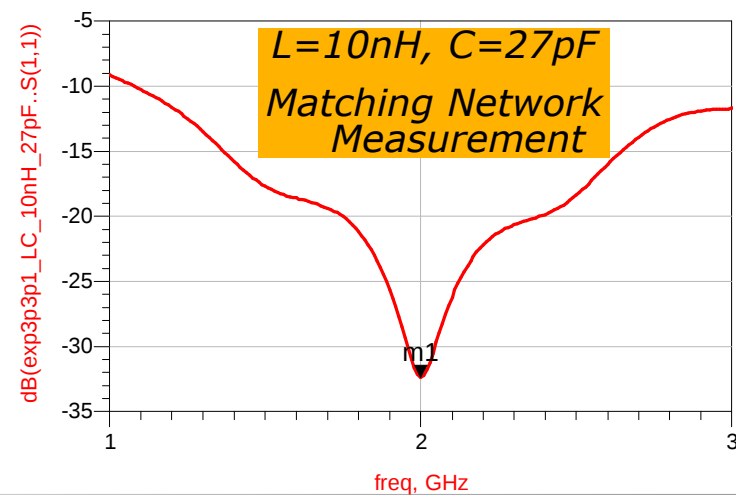
Prediction vs. Measurement for the Tuned Matching Network



Optimized Prediction for 2 GHz Match



Measured Data, M1=2.00 GHz



7. Summary

- Higher density Mini-Coax connector topology maintains electrical and improves mechanical performance.
- Optimized 50 ohm vias and stripline routing have the potential to significantly improve isolation and routing densities.
- RF matching networks are already affected by T-Line effects at 2GHz, so moving them further out for high density applications will not change the difficulty of tuning.
- The key to RF tuning is flexible matching network design and accurate measurement techniques for signal path and DUT S-Parameters.

Acknowledgements

- Verigy managers Markus Rottacker, Kosuke Miyao, and Adam Smith for supporting the High Density Loadboard Investigation Project.